TEST LOG



Article number:	A153460WS004	Sprache Language ODE OEN OFR ONL OES	O PI	
		Date: 18.10.2021		
Device status:		Bemerkungen / Remarks:		
As good as new unused		OVP beschädigt		
Damaged (light) technically inspected				
Damaged (dents/scratches) technically checked				
Signs of wear (light) technically checked				
Traces of use technically checked				

Trade fair / customer return, technically checked and fully functional.

Unit may show slight signs of use and/or slight packaging damage.